Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/764,057	CHANG ET AL.	
Examiner	Art Unit	
Brian S. Kwon	1614	

	SEAR	CHED	
Class	Subclass	Date	Examiner
514	58	7/10/06	ВК

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST, NPL	7/26/2006	bk	